

**General Description:**

The JS1P15AD3S uses advanced trench technology and design to provide excellent RDS(ON) with low gate charge. It can be used in a wide variety of applications. The package form is DFN3.3\*3.3, which accords with the RoHS standard.

**Features:**

- Fast Switching
- Low Gate Charge and Rdson
- Low Reverse transfer capacitances

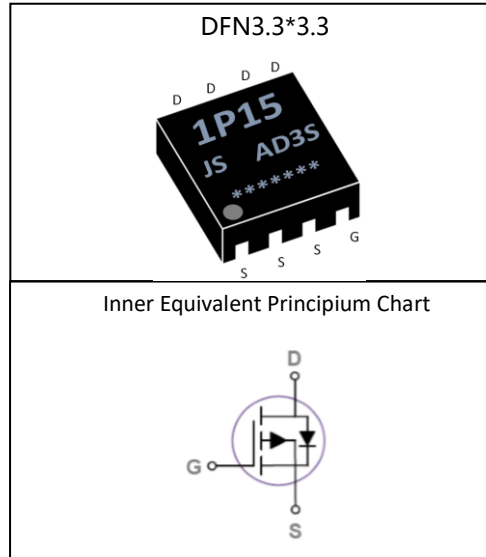
**Applications:**

- Power switching application
- Hard switched and high frequency circuits

**Package Marking and Ordering Information:**

Device Marking	Device	Device Package	Quantity
JS1P15AD3S	JS1P15AD3S	DFN3.3*3.3	5000 units

V <sub>DSS</sub>	-150	V
I <sub>D</sub>	-1	A
P <sub>D</sub>	15	W
R <sub>DS(ON)</sub> TYPE	0.650	Ω


**Absolute Maximum Ratings** (TA= 25°C unless otherwise specified):

Symbol	Parameter	Rating	Units
V <sub>DSS</sub>	Drain-to-Source Voltage	-150	V
I <sub>D</sub>	Continuous Drain Current T <sub>A</sub> = 25 °C	-1	A
	Continuous Drain Current T <sub>A</sub> = 100 °C	-0.63	A
I <sub>DM</sub>	Pulsed Drain Current	-4	A
V <sub>GS</sub>	Gate-to-Source Voltage	±20	V
P <sub>D</sub>	Power Dissipation (Note 1)	15	W
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature Range	150, -55 to 175	°C
T <sub>L</sub>	Maximum Temperature for Soldering	300	°C

Note: Drain current limited by maximum junction temperature

**Electrical Characteristics** ( $T_c = 25^\circ\text{C}$  unless otherwise specified):

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$V_{DSS}$	Drain to Source Breakdown Voltage	$V_{GS}=0V, I_D=-250\mu A$	-150	--	--	V
$I_{DSS}$	Drain to Source Leakage Current	$V_{DS} = -150V, V_{GS}= 0V,$ $T_J = 25^\circ\text{C}$	--	--	-1	$\mu A$
		$V_{DS} = -120V, V_{GS}= 0V,$ $T_J = 125^\circ\text{C}$	--	--	-10	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS} = +20V, V_{DS}= 0V$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS} = -20V, V_{DS}= 0V$	--	--	-100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=-10V, I_D=-1.0A$	--	650	800	$m\Omega$
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=-6V, I_D=-0.5A$	--	700	950	$m\Omega$
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250\mu A$	-2.0	-3.0	-4.0	V
$g_{fs}$	Forward Transconductance	$V_{DS}=-10V, I_D = -1A$	--	2	--	S
$R_g$	Gate Resistance	$V_{DS}=0V, V_{GS}=0V$ $f=1\text{MHz}$	--	30	--	$\Omega$

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$	--	430	--	$pF$
$C_{oss}$	Output Capacitance	$V_{DS} = -25V$	--	38	--	
$C_{rss}$	Reverse Transfer Capacitance	$f = 1.0\text{MHz}$	--	28	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$I_D = -1A, V_{DS} = -75V$ $V_{GS} = -10V, R_G = 10\Omega$ (Note 2, 3)	--	12.5	--	ns
$t_r$	Rise Time		--	9	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	17.3	--	
$t_f$	Fall Time		--	11.5	--	
$Q_g$	Total Gate Charge	$I_D = -1A, V_{DS} = -75V$	--	4.4	--	nC
$Q_{gs}$	Gate to Source Charge	$V_{GS} = 0 \sim -10V$	--	0.7	--	
$Q_{gd}$	Gate to Drain ( "Miller" ) Charge	(Note 2, 3)	--	1.5	--	

Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$I_S$	Continuous Source Current (Body Diode)		--	--	-1	A
$I_{SM}$	Maximum Pulsed Current (Body Diode)		--	--	-2	A
$V_{SD}$	Diode Forward Voltage	$I_S = -1A, V_{GS} = 0V$	--	--	-1.2	V

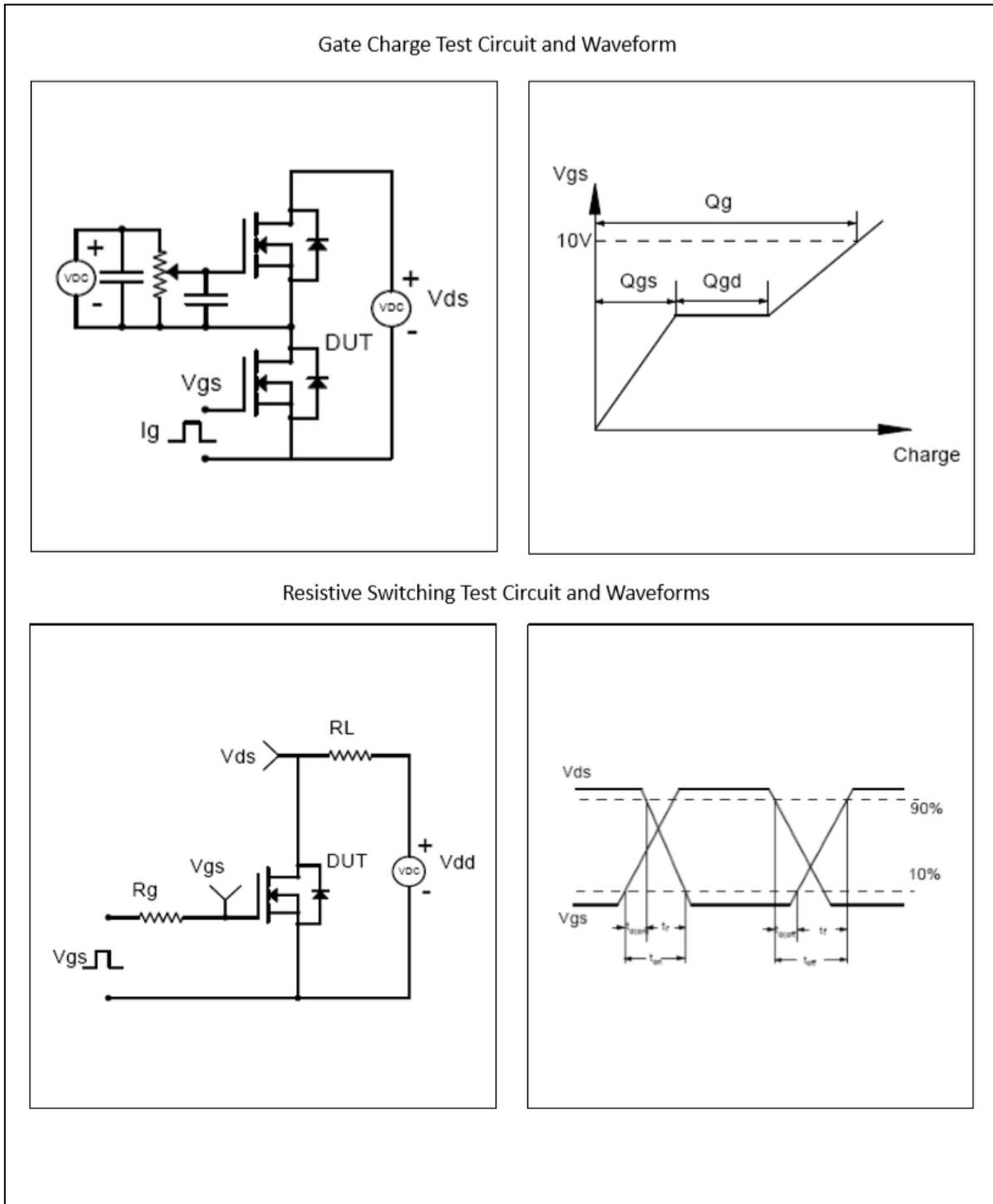
**Notes:**

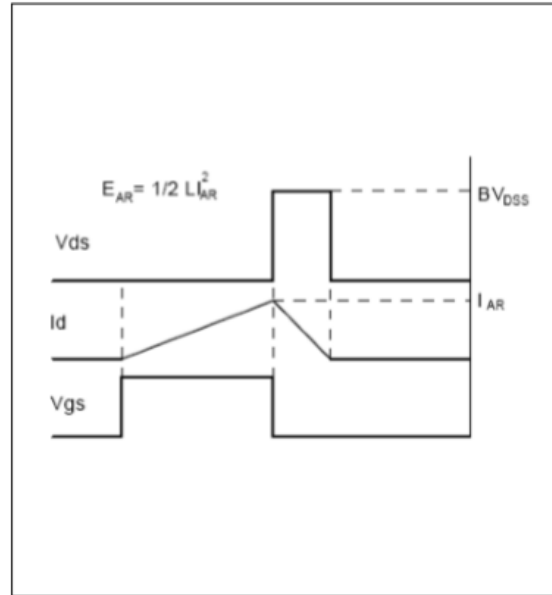
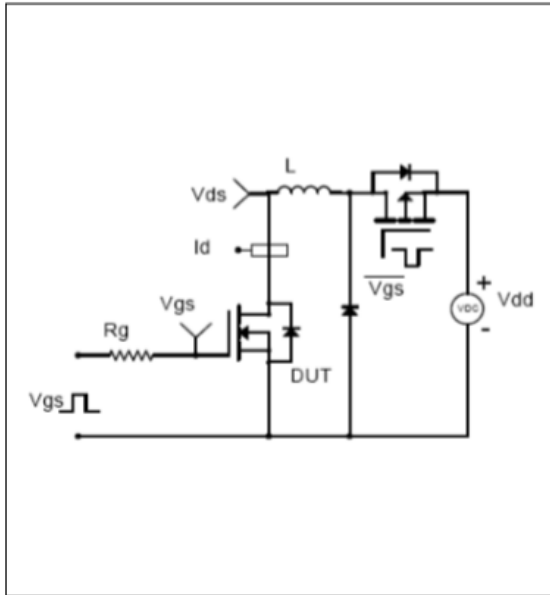
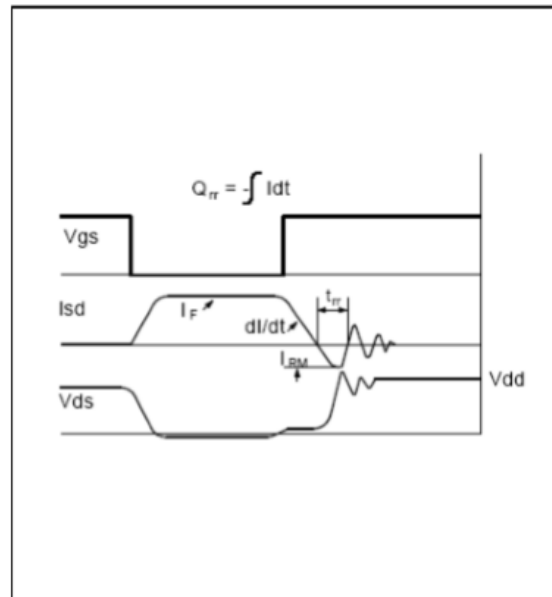
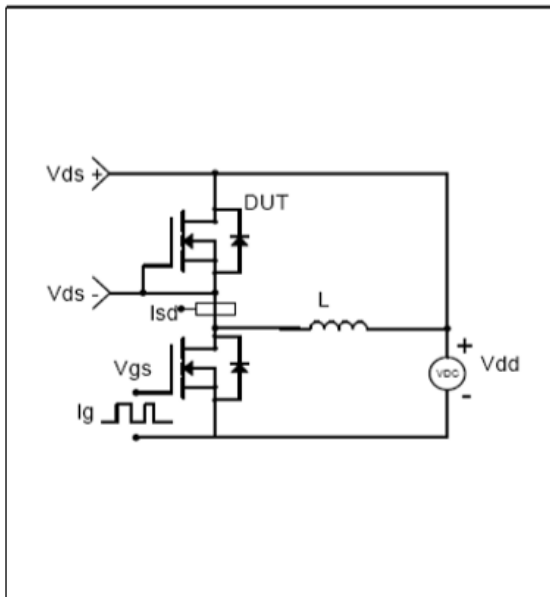
1. The power dissipation PD is based on  $T_J(\text{MAX}) = 150^\circ\text{C}$ , using  $\leq 10\text{s}$  junction-to-ambient thermal resistance
2. Pulse Test: Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
3. Essentially Independent of Operating Temperature Typical Characteristics

**Thermal Characteristics**

Symbol	Parameter	Typ.	Units
$R_{\theta JC}$	Junction-to-Case	8	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Junction-to-Ambient	40	$^\circ\text{C}/\text{W}$

### Test Circuit and Waveform



**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**

**Diode Recovery Test Circuit & Waveforms**


### Typical Performance Characteristics

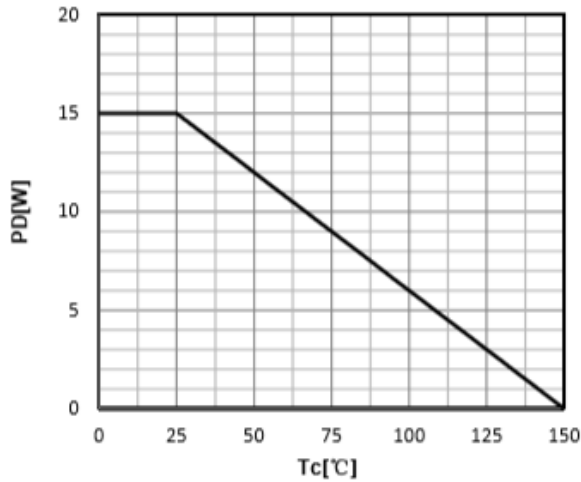


Figure 1: Power Dissipation

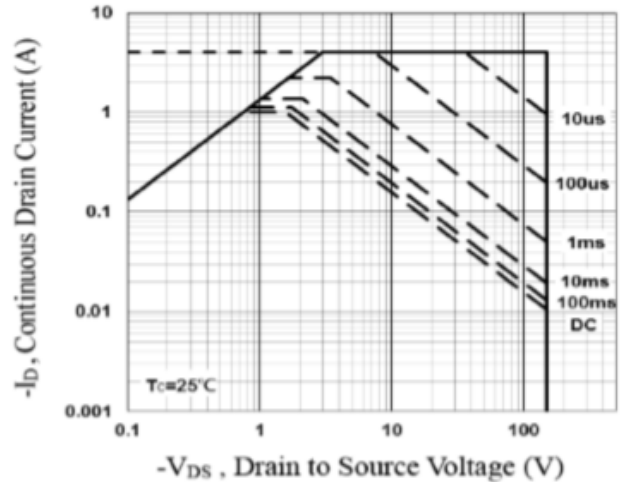


Figure 2: Maximum Forward Biased Safe Operating Area

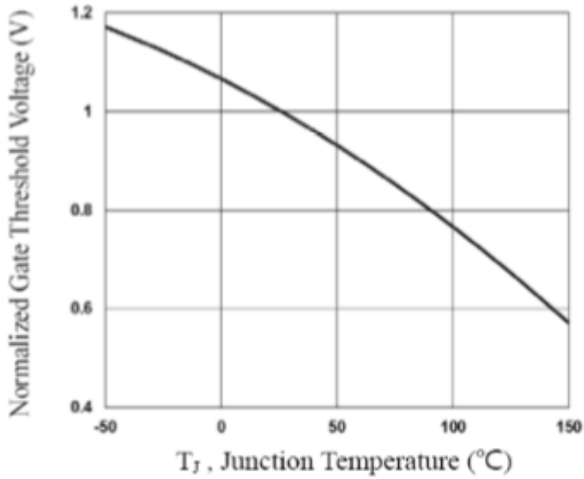


Figure 3: V<sub>th</sub> vs Junction Temperature

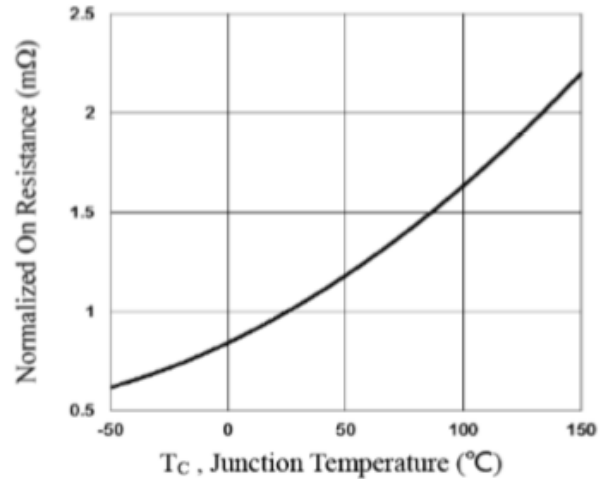


Figure 4: On-Resistance vs Junction Temperature

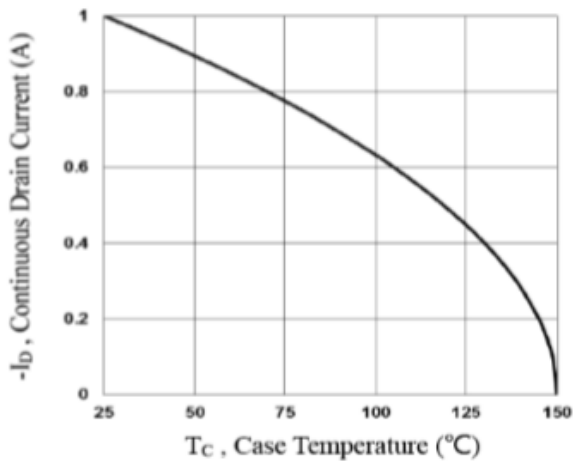


Figure 5: Drain Current vs Case Temperature

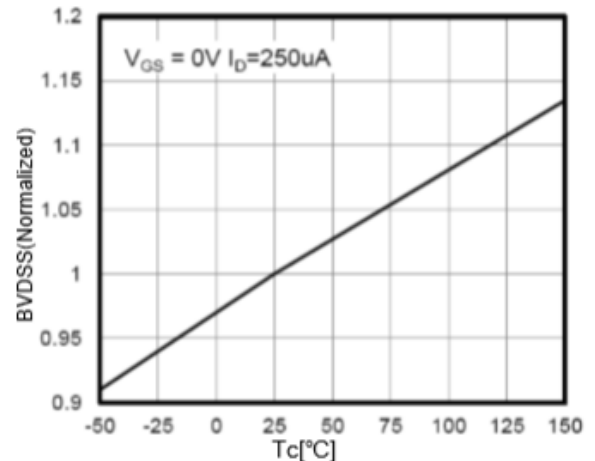


Figure 6: Drain-Source Breakdown Voltage

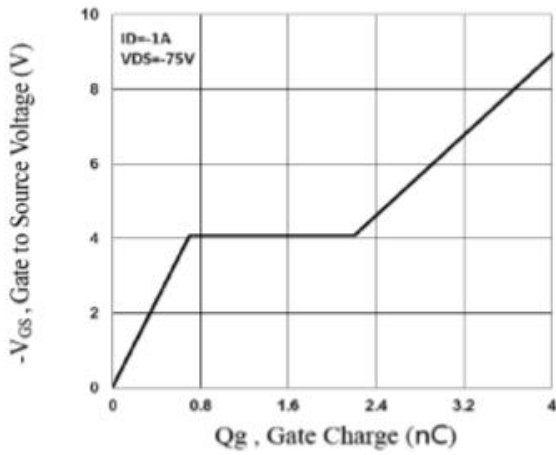


Figure 7: Gate-Charge Characteristics

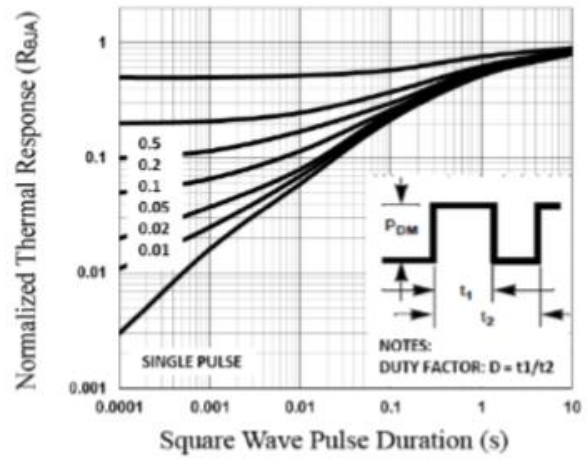
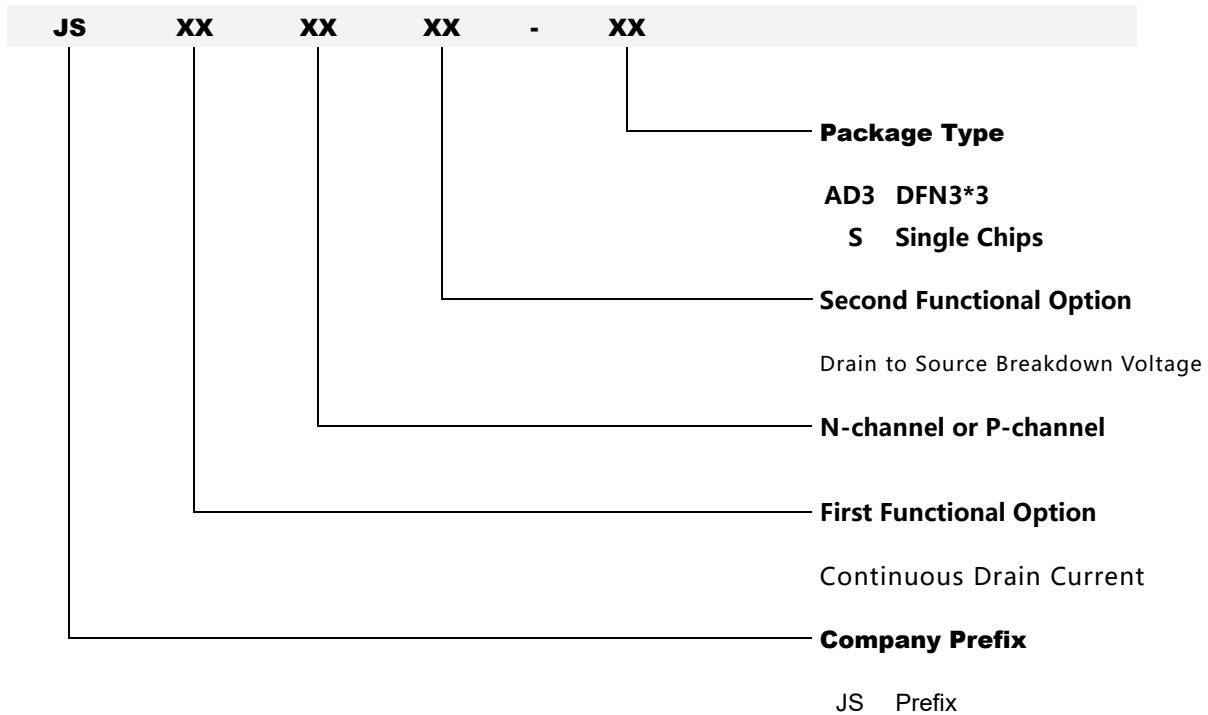


Figure 8: Normalized Transient Thermal Impedance

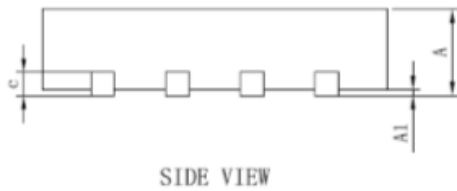
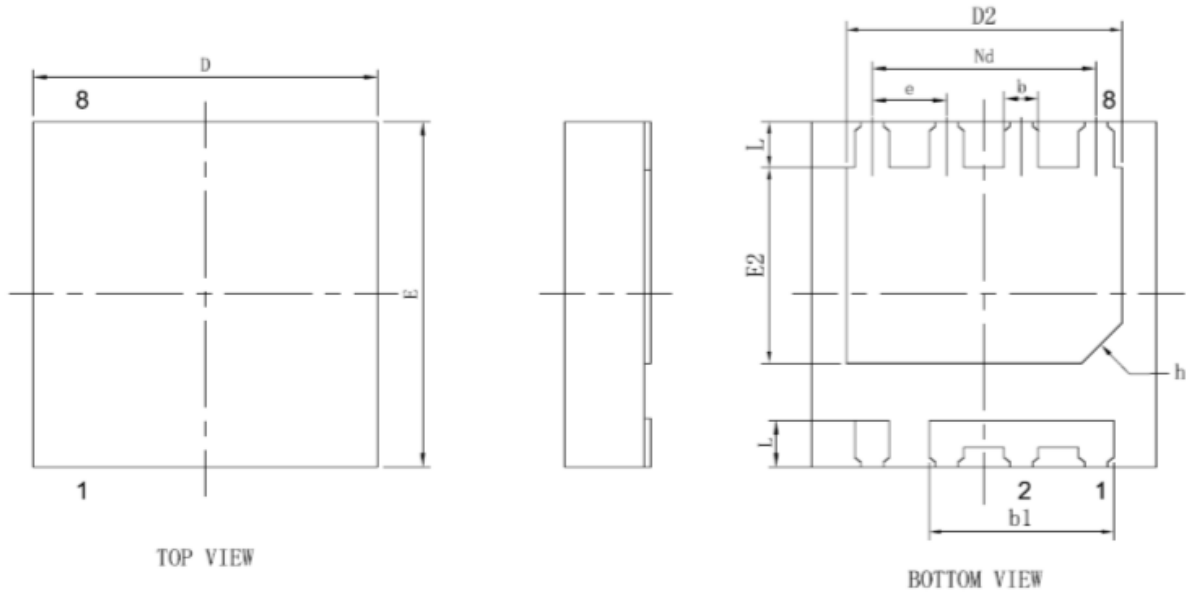
## Marking Information



	Part NO.
●	Y M W SN
Part NO.	JS1P15AD3S
●	Pin 1 Indicator
Lot NO.	Y: Year; M: Month; W: Week; SN: Pipeline Code



### Package Information



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
b	0.25	0.30	0.35
b1	1.55	1.60	1.65
c	0.19	0.20	0.21
D	2.90	3.00	3.10
D2	2.30	2.40	2.50
Nd	1.90	1.95	2.00
E	2.90	3.00	3.10
E2	1.60	1.70	1.80
e	0.65BSC		
L	0.35	0.40	0.45
h	0.30	0.35	0.40
载体尺寸 (mil)	106X83		

**Revision History**

Revision	Date	Descriptions
REV.1.1	Dec., 2018	"Typical Performance Characteristics" Update
REV.1.0	July, 2017	Initial Version